

Search Notes	Application/Control No.	Applicant(s)/Patent Under Reexamination
	10711682	CHAU, CHUNG-NIN
	Examiner	Art Unit
	HEVEY, JOHN A	4116

SEARCHED

Class	Subclass	Date	Examiner
252	301.4F, 301.6R, 301.6S, 301.6F	1/24/2008	jah

SEARCH NOTES

Search Notes	Date	Examiner
EAST -see search history	1/24/2008	jah
PALM inventor search	1/24/2008	jah

INTERFERENCE SEARCH

Class	Subclass	Date	Examiner